Engineering Test Report No. 2203597-01		
Report Date	November 28, 2022	
Manufacturer Name	Badger Meter, Incorporated	
Manufacturer Address	4545 W. Brown Deer Road Milwaukee, WI 53223	
Model No.	Badger Touch	
Date Received	November 16, 2022	
Test Dates	November 16, 2022	
Specifications	FCC "Code of Federal Regulations" Title 47 Part 15, Subpart C, Section 15.209 Innovation, Science, and Economic Development Canada, RSS-GEN	
Test Facility	Elite Electronic Engineering, Inc. 1516 Centre Circle, Downers Grove, IL 60515	FCC Reg. Number: 269750 IC Reg. Number: 2987A CAB Identifier: US0107
Signature	Nathaniel Bouchie	
Tested by	Nathaniel Bouchie	
Signature	Raymond J Klouda	
Approved by	Raymond J. Klouda, Registered Professional Engineer of Illinois – 44894	
PO Number	446166	

Elite Electronic Engineering Incorporated certifies that the information contained in this report was obtained under conditions which meet or exceed those specified in the FCC "Code of Federal Regulations" Title 47 Part 15, Subpart C, Section 15.209 and Innovation, Science, and Economic Development Canada, RSS-GEN test specifications. The data presented in this test report pertains to the EUT on the test date specified. Any electrical or mechanical modifications made to the EUT subsequent to the specified test date will serve to invalidate the data and void this certification. This report must not be used to claim product certification, approval, or endorsement by A2LA, NIST, or any agency of the Federal Government.

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1. Report Revision History

Revision	Date	Description
–	28 NOV 2022	Initial Release of Engineering Test Report No. 2203597-01

2. Introduction

2.1. Scope of Tests

This document presents the results of a series of RF emissions tests that were performed on the Badger Meter, Incorporated High Resolution Encoder Transmitter (hereinafter referred to as the Equipment Under Test (EUT)). The EUT was manufactured and submitted for testing by Badger Meter, Incorporated located in Milwaukee, WI.

2.2. Purpose

The test series was performed to determine if the EUT meets the RF emission requirements of the FCC "Code of Federal Regulations" Title 47, Part 15, Subpart C, Sections 15.209.

The test series was also performed to determine if the EUT meets the RF emission requirements of the Industry Canada Radio Standards Specification RSS-Gen.

Testing was performed in accordance with ANSI C63.10-2013.

2.3. Identification of the EUT

The EUT was identified as follows:

EUT Identification	
Product Description	High Resolution Encoder Transmitter
Model/Part No.	Badger Touch
S/N	Sample 1
Band of Operation	N/A
Modulation Type	On/Off at 1200 Baud Rate
Software/Firmware Version	7.0.5
99% Bandwidth	3.766kHz
Size of EUT	3.5 in x 3.5 in x 2.25 in

The EUT listed above was used throughout the test series.

3. Power Input

The EUT was powered by 5V from a twisted pair connected to a signal generator.

4. Grounding

The EUT was not connected to ground.

5. Support Equipment

The EUT was submitted for testing along with the following support equipment:

Description	Model #	S/N
Signal Generator	N/A	N/A

6. Interconnect Leads

The following interconnect cables were submitted with the test item:

Item	Description
2-Wire I/O	Connects Signal Generator to EUT

7. Modifications Made to the EUT

No modifications were made to the EUT during the testing.

8. Modes of Operation

Mode	Description
Tx @ 50kHz	The EUT was set to transmit at 50kHz

9. Test Specifications

The tests were performed to selected portions of, and in accordance with the FCC "Code of Federal Regulations" Title 47 Part 15, Subpart C, Section 15.209 and Innovation, Science, and Economic Development Canada, RSS-GEN test specifications.

- Federal Communications Commission “Code of Federal Regulations”, Title 47, Part 15, Subpart C
- ANSI C63.4-2014, “American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9kHz to 40 GHz”
- ANSI C63.10-2013, “American National Standard of Procedures for Compliance Testing of Unlicensed Wireless Devices”
- RSS-Gen Issue 5, March 2019, Amendment 1, Innovation, Science, and Economic Development Canada, “Spectrum Management and Telecommunications, Radio Standards Specification, General Requirements for Compliance of Radio Apparatus”

10. Test Plan

No test plan was provided. Instructions were provided by personnel from Badger Meter, Incorporated and used in conjunction with the FCC "Code of Federal Regulations" Title 47 Part 15, Subpart C, Section 15.209, Innovation, Science, and Economic Development Canada, RSS-GEN, and ANSI C63.4-2014 specifications.

11. Deviation, Additions to, or Exclusions from Test Specifications

There were no deviations, additions to, or exclusions from the test specifications during this test series.

12. Laboratory Conditions

Ambient Parameters	Value
Temperature	23.9°C
Relative Humidity	23%
Atmospheric Pressure	1019.0mb

13. Summary

The following EMC tests were performed, and the results are shown below:

Test Description	Requirements	Test Methods	S/N	Results
Occupied Bandwidth Measurement	FCC 15C RSS-GEN	ANSI C63.10: 2013	Sample 1	Conforms
Spurious Radiated Emissions	FCC 15C ISED RSS-GEN	ANSI C63.10: 2013	Sample 1	Conforms

14. Sample Calculations

For Powerline Conducted Emissions:

The resultant voltage level (VL) is a summation in decibels (dB) of the receiver meter reading (MTR) and the cable loss factor (CF).

Formula 1: VL (dBuV) = MTR (dBuV) + CF (dB).

For Radiated Emissions:

The resultant field strength (FS) is a summation in decibels (dB) of the receiver meter reading (MTR), the antenna correction factor (AF), and the cable loss factor (CF). If an external preamplifier is used, the total is reduced by its gain (-PA). If a distance correction (DC) is required, it is added to the total.

Formula 1: FS (dBuV/m) = MTR (dBuV) + AF (dB/m) + CF (dB) + (- PA (dB)) + DC (dB)

To convert the Field Strength dBuV/m term to uV/m, the dBuV/m is first divided by 20. The Base 10 AntiLog is taken of this quotient. The result is the Field Strength value in uV/m terms.

Formula 2: FS (uV/m) = AntiLog [(FS (dBuV/m))/20]

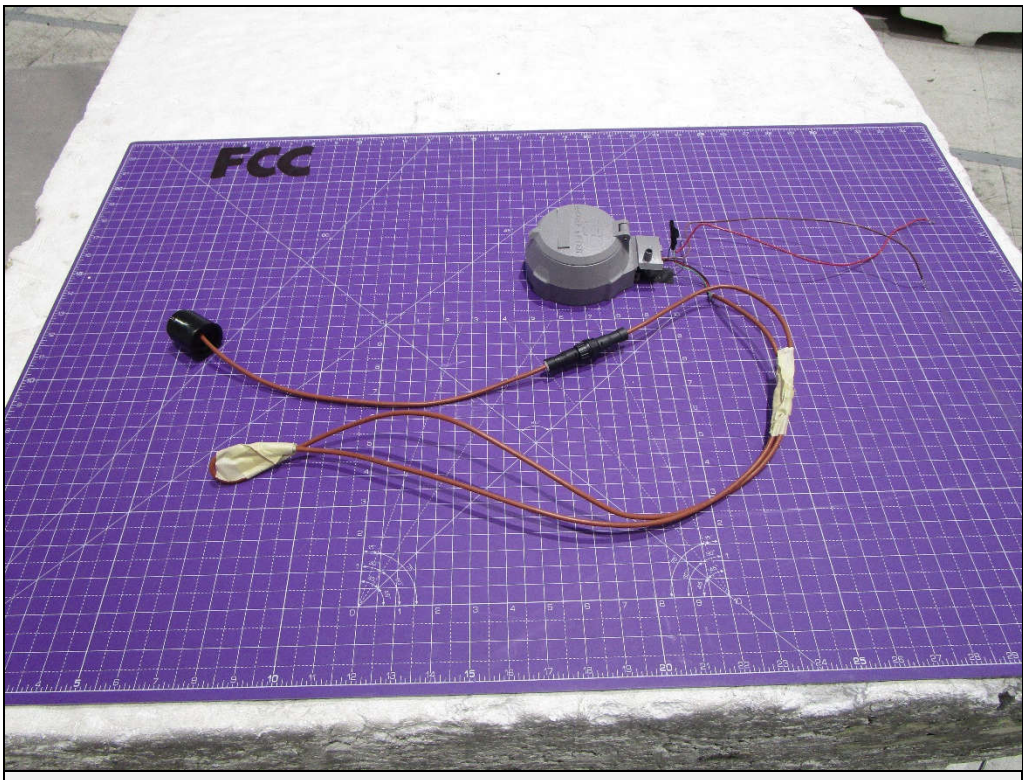
15. Statement of Conformity

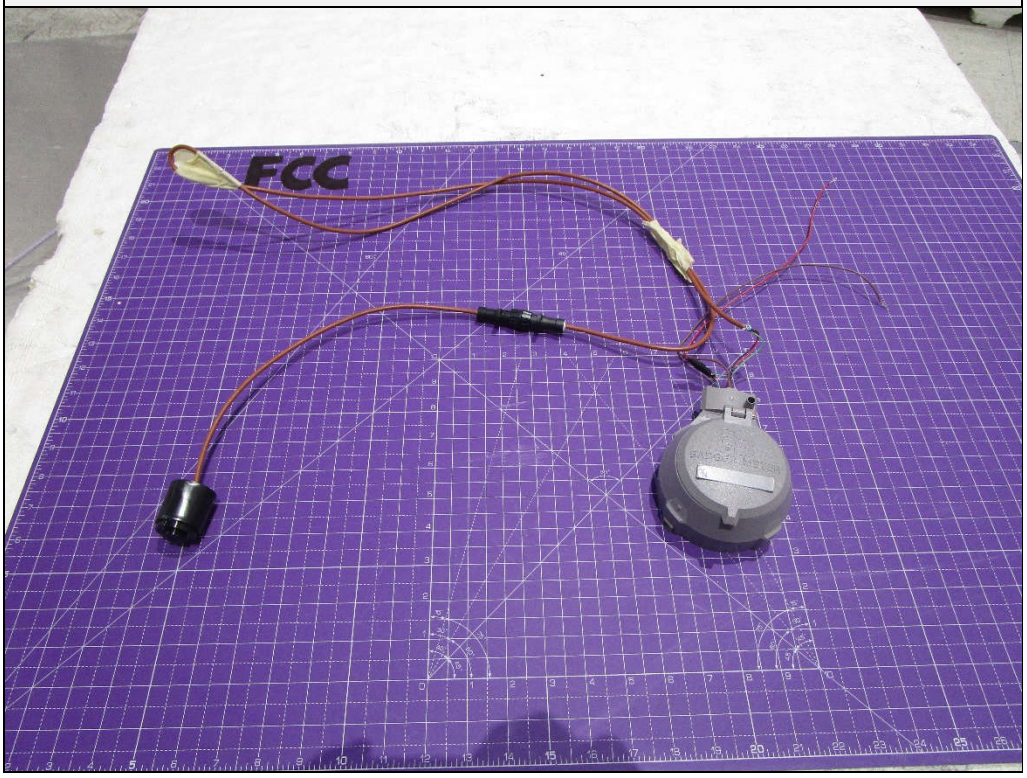
The Badger Meter, Incorporated High Resolution Encoder Transmitter, Model No. Badger Touch, Serial No. Sample 1, did fully conform to the selected requirements of FCC "Code of Federal Regulations" Title 47 Part 15, Subpart C, Section 15.209 and Innovation, Science, and Economic Development Canada, RSS-GEN.

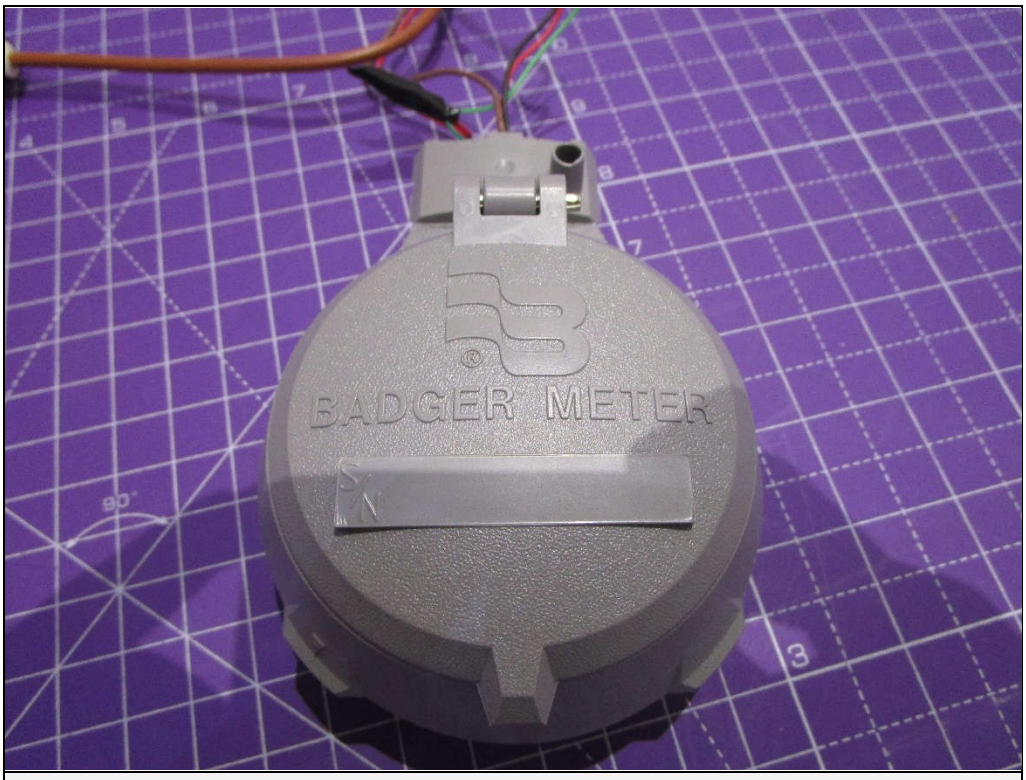
16. Certification

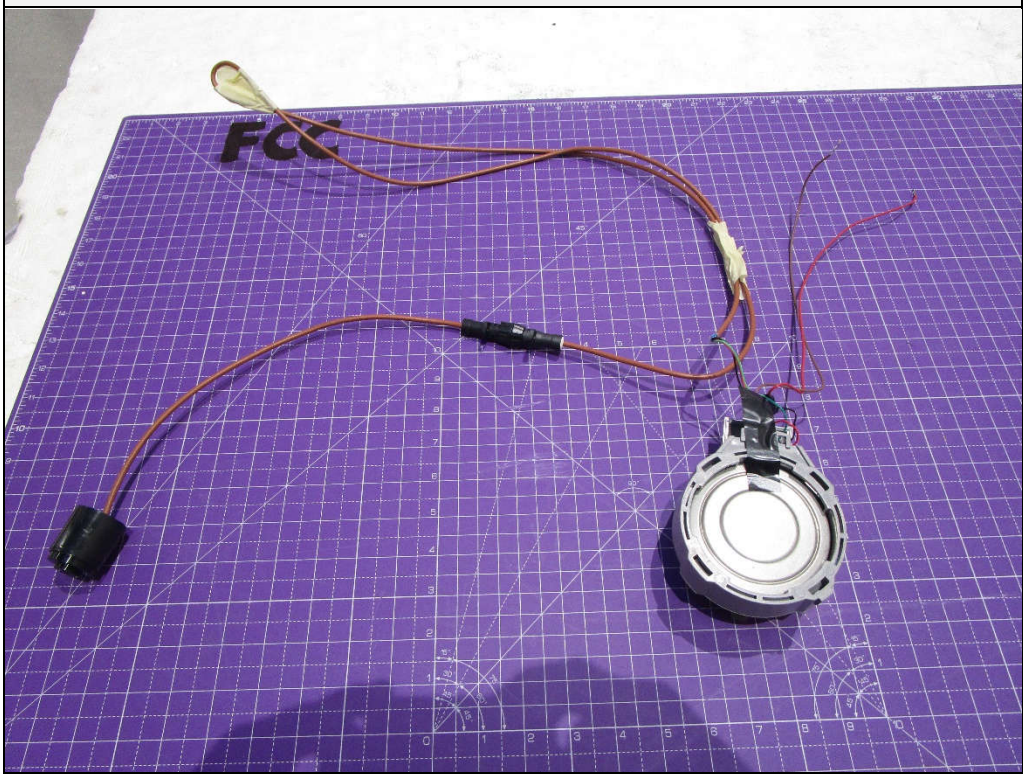
Elite Electronic Engineering Incorporated certifies that the information contained in this report was obtained under conditions which meet or exceed those specified in the FCC "Code of Federal Regulations" Title 47 Part 15, Subpart C, Section 15.209 and Innovation, Science, and Economic Development Canada, RSS-GEN test specifications. The data presented in this test report pertains to the EUT on the test date specified. Any electrical or mechanical modifications made to the EUT subsequent to the specified test date will serve to invalidate the data and void this certification.

17. Photographs of EUT






BADGER METER
S/N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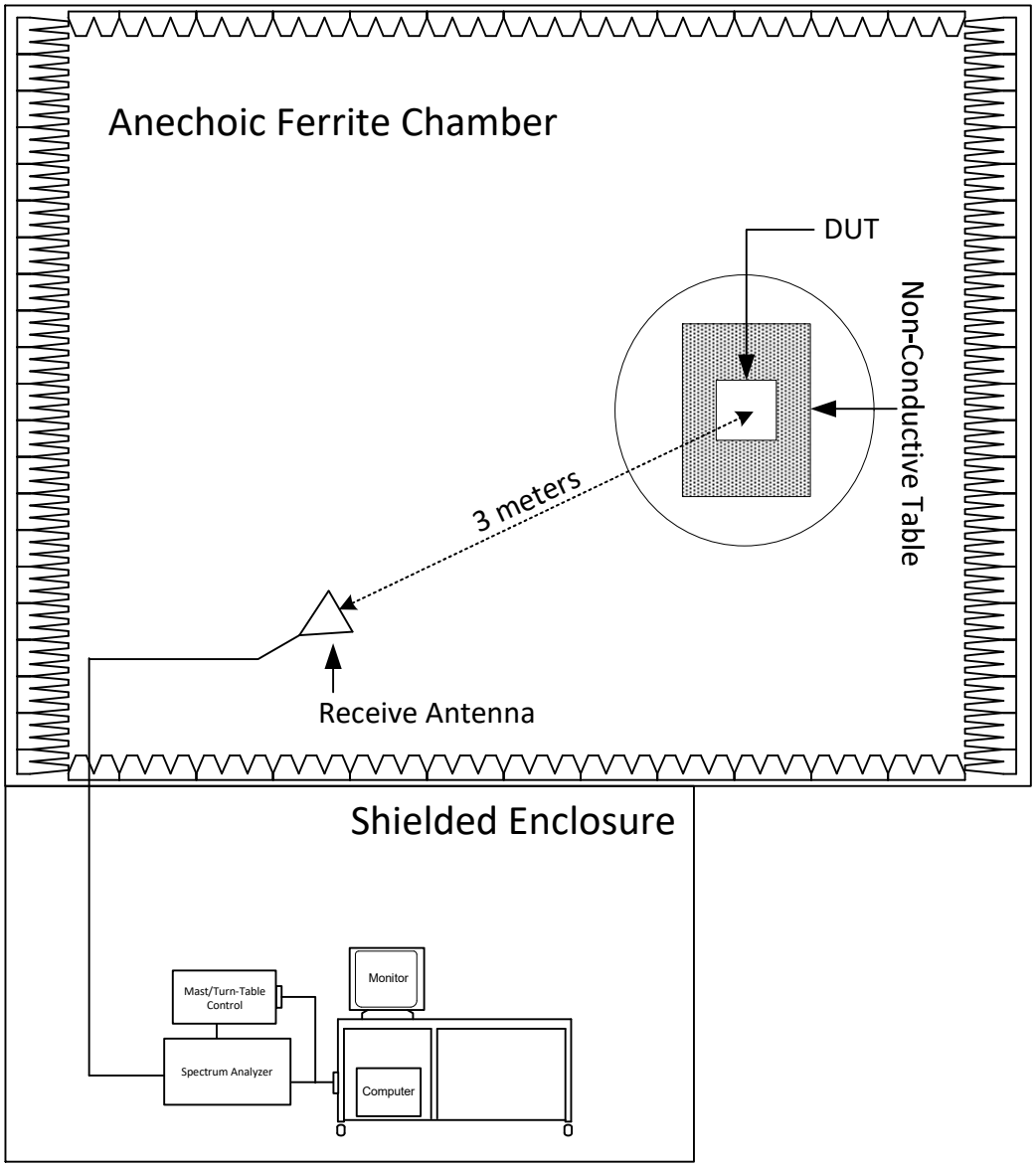
18. Equipment List

Eq ID	Equipment Description	Manufacturer	Model No.	Serial No.	Frequency Range	Cal Date	Due Date
CDZ3	LAB WORKSTATION	ELITE	LWS-10		WINDOWS 10	CNR	
NLS0	24" ACTIVE LOOP ANTENNA	EMCO	6502	89979	10KHZ-30MHZ	9/26/2022	9/26/2024
NLS1	24" ACTIVE LOOP ANTENNA	EMCO	6502	8903-2329	0.01-30MHZ	8/31/2022	8/31/2024
NSDS1	UNIVERSAL SPHERICAL DIPOLE SOURCE	AET	USDS-H	AET-1116		NOTE 1	
R29F	3M ANECHOIC CHAMBER NSA	EMC TEST SYSTEMS	3M ANECHOIC		30MHZ-18GHZ	3/25/2022	3/25/2023
RBG2	EMI ANALYZER	ROHDE & SCHWARZ	ESW44	101591	2HZ-44GHZ	3/31/2022	3/31/2023
VBV2	CISPR EN FCC ICES RE.EXE	ELITE	CISPR EN FCC ICES RE.EXE	---	---	N/A	

N/A: Not Applicable I/O: Initial Only CNR: Calibration Not Required
NOTE 1: For the purpose of this test, the equipment was calibrated over the specified frequency range, pulse rate, or modulation prior to the test or monitored by a calibrated instrument.

19. Block Diagram of Test Setup



Radiated Measurements Test Setup

20. Occupied Bandwidth Measurements

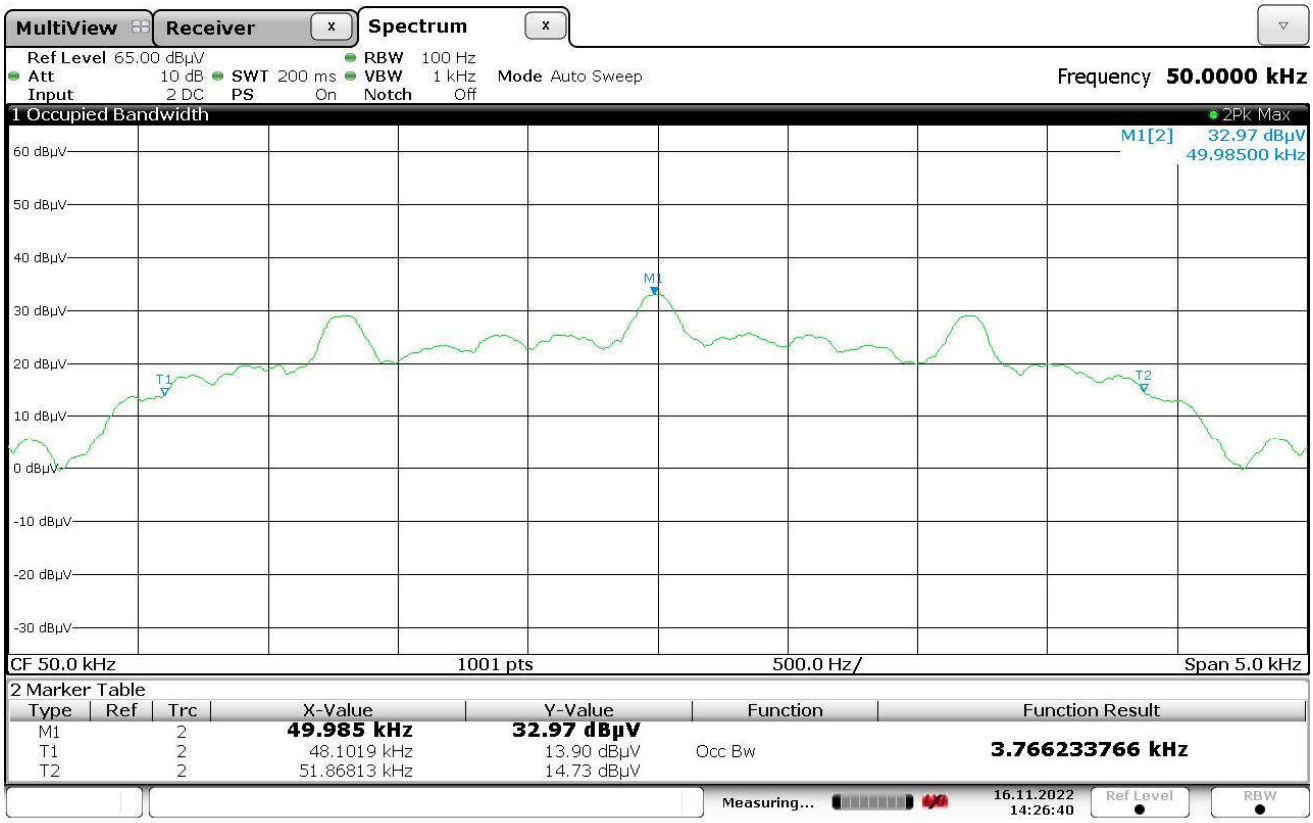
Test Information	
Manufacturer	Badger Meter, Incorporated
Product	High Resolution Encoder Transmitter
Model	Badger Touch
Serial No	Sample 1
Mode	Tx @ 50kHz
Test Date	November 16, 2022

Test Setup Details	
Setup Format	Tabletop
Height of Support	N/a
Type of Test Site	Semi-Anechoic Chamber
Test site used	Room 29
Notes	None

Measurement Uncertainty	
Measurement Type	Expanded Measurement Uncertainty
Radiated disturbance (electric field strength on an open area test site or alternative test site) (30 MHz – 1000 MHz)	4.3
Radiated disturbance (electric field strength on an open area test site or alternative test site) (1 GHz – 6 GHz)	3.1
Radiated disturbance (electric field strength on an open area test site or alternative test site) (6 GHz – 18 GHz)	3.2
Radiated disturbance (electric field strength on an open area test site or alternative test site) (18 GHz – 26.5 GHz)	3.3
Radiated disturbance (electric field strength on an open area test site or alternative test site) (26.5 GHz – 40 GHz)	3.4

Procedures
The EUT was placed on an 80cm high non-conductive stand. The unit was set to transmit continuously. With an antenna positioned nearby, occupied bandwidth emissions were displayed on the spectrum analyzer. The resolution bandwidth was set to 1% to 5% of the actual occupied bandwidth and span was set to 2MHz. The 99% Power Bandwidth function of the spectrum analyzer was enabled. A screen capture was taken of the frequency spectrum near the carrier using a screen dump function on the spectrum analyzer.

Test Details	
Manufacturer	Badger Meter, Incorporated
Model	Badger Touch
S/N	Sample 1
Mode	Tx @ 50kHz
Carrier Frequency	50kHz
Parameters	Occupied Bandwidth (99% Bandwidth) = 3.766kHz
Notes	None



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21. Spurious Radiated Emissions

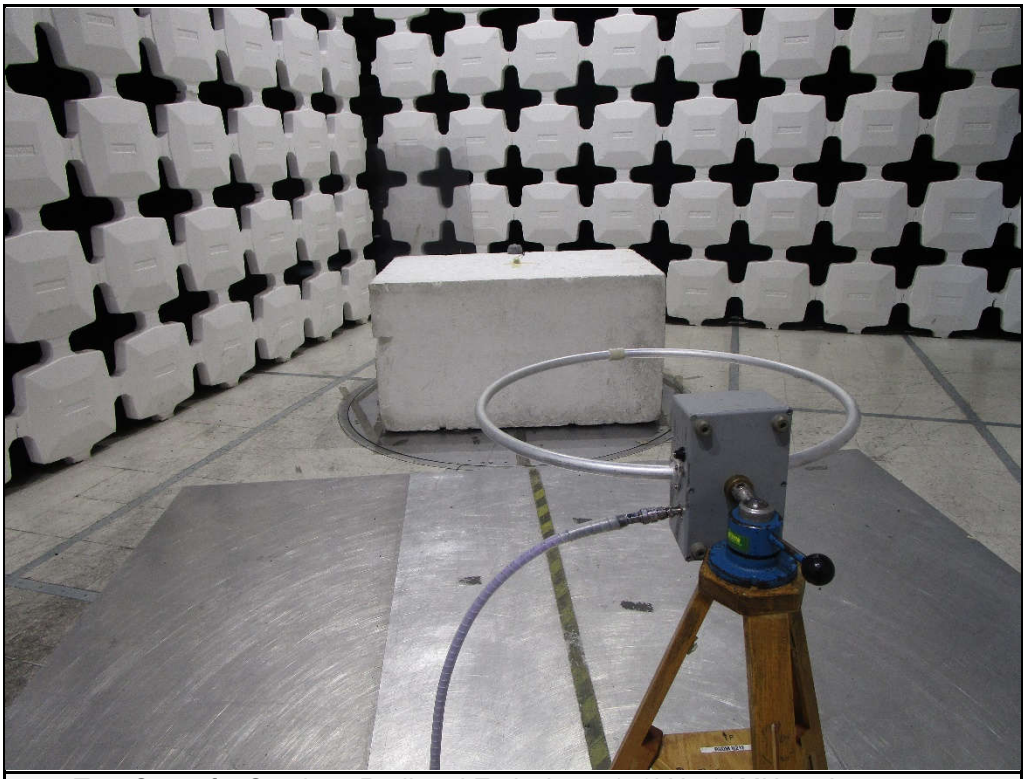
Test Information	
Manufacturer	Badger Meter, Incorporated
Product	High Resolution Encoder Transmitter
Model	Badger Touch
Serial No	Sample 1
Mode	Tx @ 50kHz

Test Setup Details	
Setup Format	Tabletop
Height of Support	N/a
Measurement Method	Radiated
Type of Test Site	Semi-Anechoic Chamber
Test site used	Room 29
Type of Antennas Used	Loop (or equivalent)
Notes	None

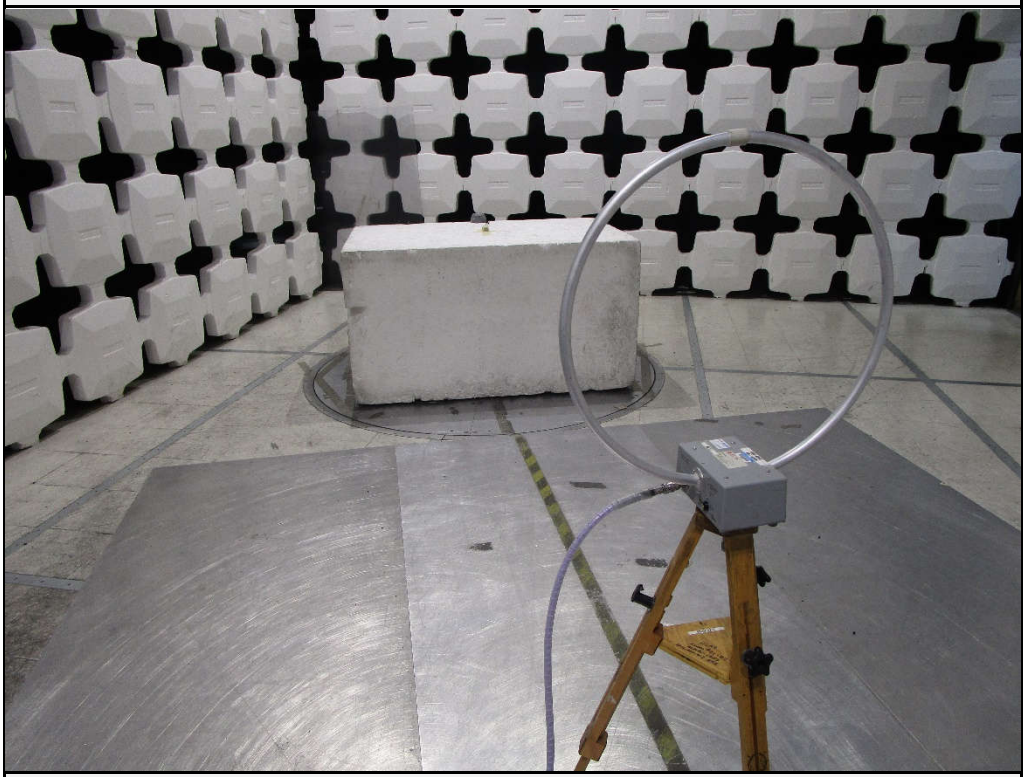
Measurement Uncertainty	
Measurement Type	Expanded Measurement Uncertainty
Radiated disturbance (electric field strength on an open area test site or alternative test site) (30 MHz – 1000 MHz)	4.3
Radiated disturbance (electric field strength on an open area test site or alternative test site) (1 GHz – 6 GHz)	3.1
Radiated disturbance (electric field strength on an open area test site or alternative test site) (6 GHz – 18 GHz)	3.2
Radiated disturbance (electric field strength on an open area test site or alternative test site) (18 GHz – 26.5 GHz)	3.3
Radiated disturbance (electric field strength on an open area test site or alternative test site) (26.5 GHz – 40 GHz)	3.4

Requirements		
The field strength of radiated emissions from intentional radiators at a distance of 3 meters shall not exceed the following values:		
Fundamental Frequency	Field Strength (μV/m)	Measurement Distance (m)
0.009 – 0.490 MHz	2400/F(kHz)	300
0.490 – 1.705 MHz	24000/F(kHz)	30
1.705 – 30.0 MHz	30	30
30 – 80 MHz	100	3
88 – 216 MHz	150	3
216 – 960 MHz	200	3
Above 960 MHz	500	3

Procedures
Radiated measurements were performed in a 32ft. x 20ft. x 14ft. high shielded enclosure. The shielded enclosure prevents emissions from other sources, such as radio and TV stations from interfering with the measurements. All powerlines and signal lines entering the enclosure pass through filters on the enclosure wall. The powerline filters prevent extraneous signals from entering the enclosure on these leads. Preliminary radiated emissions tests were performed to determine the emission characteristics of the EUT. For the preliminary test, a broadband measuring antenna was positioned at a 3-meter distance from the EUT. The entire frequency range from 150kHz to 30MHz was investigated using a peak detector function. The final open field emission tests were then manually performed over the frequency range of 150kHz to 30MHz. a) The field strength of the fundamental was measured using a loop antenna. The loop antenna was positioned at a 3-meter distance from the EUT. The EUT was 80cm high non-conductive stand. A quasi-peak detector with a resolution bandwidth of 200Hz was used on the spectrum analyzer. b) To ensure that maximum or worst-case emission levels at the fundamental and harmonics were measured, the following steps were taken when measuring the fundamental emissions and the spurious emissions: i) The EUT was rotated so that all of its sides were exposed to the receiving antenna. When the position that corresponded to the maximum emissions was found, the antenna was spun 90^{o} to further maximize the emissions. ii) Since the measuring antenna is linearly polarized, both horizontal and vertical field components were measured.



Test Setup for Spurious Radiated Emissions, 150kHz-30MHz – Antenna Polarization Horizontal



Test Setup for Spurious Radiated Emissions, 150kHz-30MHz – Antenna Polarization Vertical

Test Details	
Manufacturer	Badger Meter, Incorporated
Model	Badger Touch
S/N	Sample 1
Mode	Tx @ 50kHz
Carrier Frequency	50kHz
Parameters	Quasi-Peak Measurements
Notes	15.209 Limits

Freq. (MHz)	Ant Pol	Meter Reading (dBuV)	Ambient	CBL Fac (dB)	Ant Fac (dB/m)	Pre Amp (dB)	Dist. Corr. (dB)	Total (dBuV/m)	Total (uV/m)	Limit (uV/m)	Specified Test Distance (meters)	Margin (dB)
0.050	H	30.3	*	0.0	11.4	0.0	-80.0	-38.3	0.0	48.0	300.0	-72.0
0.050	V	30.7	*	0.0	11.4	0.0	-80.0	-37.9	0.0	48.0	300.0	-71.6
0.100	H	25.0	*	0.0	10.7	0.0	-80.0	-44.3	0.0	24.0	300.0	-71.9
0.100	V	24.7	*	0.0	10.7	0.0	-80.0	-44.6	0.0	24.0	300.0	-72.2
0.150	H	40.5	*	0.0	10.6	0.0	-80.0	-28.9	0.0	16.0	300.0	-53.0
0.150	V	40.4	*	0.0	10.6	0.0	-80.0	-29.0	0.0	16.0	300.0	-53.1
0.200	H	38.2	*	0.0	10.6	0.0	-80.0	-31.2	0.0	12.0	300.0	-52.8
0.200	V	38.3	*	0.0	10.6	0.0	-80.0	-31.1	0.0	12.0	300.0	-52.7
0.250	H	36.2	*	0.0	10.6	0.0	-80.0	-33.2	0.0	9.6	300.0	-52.9
0.250	V	36.3	*	0.0	10.6	0.0	-80.0	-33.1	0.0	9.6	300.0	-52.8
0.300	H	34.9	*	0.0	10.6	0.0	-80.0	-34.5	0.0	8.0	300.0	-52.6
0.300	V	34.9	*	0.0	10.6	0.0	-80.0	-34.5	0.0	8.0	300.0	-52.6
0.350	H	33.7	*	0.0	10.6	0.0	-80.0	-35.7	0.0	6.9	300.0	-52.4
0.350	V	33.6	*	0.0	10.6	0.0	-80.0	-35.8	0.0	6.9	300.0	-52.5
0.400	H	32.6	*	0.0	10.6	0.0	-80.0	-36.8	0.0	6.0	300.0	-52.4
0.400	V	32.5	*	0.0	10.6	0.0	-80.0	-36.9	0.0	6.0	300.0	-52.5
0.450	H	31.5	*	0.0	10.6	0.0	-80.0	-37.9	0.0	5.3	300.0	-52.5
0.450	V	31.3	*	0.0	10.6	0.0	-80.0	-38.1	0.0	5.3	300.0	-52.7
0.500	H	30.5	*	0.0	10.6	0.0	-40.0	1.1	1.1	48.0	30.0	-32.5
0.500	V	30.4	*	0.0	10.6	0.0	-40.0	1.0	1.1	48.0	30.0	-32.6

Test Details	
Manufacturer	Badger Meter, Incorporated
Model	Badger Touch
S/N	Sample 1
Mode	Tx @ 50kHz
Carrier Frequency	50kHz
Parameters	Quasi-Peak Measurements
Notes	RSS-Gen Limits

Freq (MHz)	Ant Pol	Meter Reading (dBµV)	Ambient	Cable Factor (dB)	Antenna Factor (dB/m)	Pre Amp (dB)	Distance Correction (dB)	Total (dBµA/m)	Total (µA/m)	Limit (µA/m)	Margin (dBm)
0.05	H	30.3	*	0.0	-40.2	0.0	-80.000	-89.860	0.000	0.1	-72.0
	V	30.7	*	0.0	-40.2	0.0	-80.000	-89.460	0.000	0.1	-71.6
0.10	H	25.0	*	0.0	-40.8	0.0	-80.000	-95.834	0.000	0.1	-71.9
	V	24.7	*	0.0	-40.8	0.0	-80.000	-96.134	0.000	0.1	-72.2
0.15	H	40.5	*	0.0	-41.0	0.0	-80.000	-80.457	0.000	0.0	-53.0
	V	40.4	*	0.0	-41.0	0.0	-80.000	-80.557	0.000	0.0	-53.1
0.20	H	38.2	*	0.0	-41.0	0.0	-80.000	-82.758	0.000	0.0	-52.8
	V	38.3	*	0.0	-41.0	0.0	-80.000	-82.658	0.000	0.0	-52.7
0.25	H	36.2	*	0.0	-41.0	0.0	-80.000	-84.759	0.000	0.0	-52.9
	V	36.3	*	0.0	-41.0	0.0	-80.000	-84.659	0.000	0.0	-52.8
0.30	H	34.9	*	0.0	-41.0	0.0	-80.000	-86.055	0.000	0.0	-52.6
	V	34.9	*	0.0	-41.0	0.0	-80.000	-86.055	0.000	0.0	-52.6
0.35	H	33.7	*	0.0	-41.0	0.0	-80.000	-87.252	0.000	0.0	-52.5
	V	33.6	*	0.0	-41.0	0.0	-80.000	-87.352	0.000	0.0	-52.6
0.40	H	32.6	*	0.0	-40.9	0.0	-80.000	-88.349	0.000	0.0	-52.4
	V	32.5	*	0.0	-40.9	0.0	-80.000	-88.449	0.000	0.0	-52.5
0.45	H	31.5	*	0.0	-40.9	0.0	-80.000	-89.447	0.000	0.0	-52.5
	V	31.3	*	0.0	-40.9	0.0	-80.000	-89.647	0.000	0.0	-52.7
0.50	H	30.5	*	0.0	-40.9	0.0	-40.000	-50.444	0.003	0.1	-32.5
	V	30.4	*	0.0	-40.9	0.0	-40.000	-50.544	0.003	0.1	-32.6

22. Scope of Accreditation

SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017

ELITE ELECTRONIC ENGINEERING, INC.
1516 Centre Circle
Downers Grove, IL 60515
Robert Bugielski (QA Manager) Phone: 630 495 9770 ext. 168
Email: rbugielski@elitetest.com
Craig Fanning (EMC Lab Manager) Phone: 630 495 9770 ext. 112
Email: cfanning@elitetest.com
Brandon Lugo (Automotive Team Leader) Phone: 630 495 9770 ext. 163
Email: blugo@elitetest.com
Richard King (FCC/Commercial Team Leader) Phone: 630 495 9770 ext. 123
Email: reking@elitetest.com
Website: www.elitetest.com

ELECTRICAL

Valid To: June 30, 2023 Certificate Number: 1786.01

In recognition of the successful completion of the A2LA Accreditation Program evaluation process, accreditation is granted to this laboratory to perform the following automotive electromagnetic compatibility and other electrical tests:

Test Technology:	Test Method(s) [1]:
Transient Immunity	ISO 7637-2 (including emissions); ISO 7637-3; ISO 16750-2:2012, Sections 4.6.3 and 4.6.4; CS-11979, Section 6.4; CS.00054, Section 5.9; EMC-CS-2009.1 (CI220); FMC1278 (CI220, CI221, CI222); GMW 3097, Section 3.5; SAE J1113-11; SAE J1113-12; ECE Regulation 10.06 Annex 10
Electrostatic Discharge (ESD)	ISO 10605 (2001, 2008); CS-11979 Section 7.0; CS.00054, Section 5.10; EMC-CS-2009.1 (CI 280); FMC1278 (CI280); SAE J1113-13; GMW 3097 Section 3.6
Conducted Emissions	CISPR 25 (2002, 2008), Sections 6.2 and 6.3; CISPR 25 (2016), Sections 6.3 and 6.4; CS-11979, Section 5.1; CS.00054, Sections 5.6.1 and 5.6.2; GMW 3097, Section 3.3.2; EMC-CS-2009.1 (CE 420); FMC1278 (CE420, CE421)
Radiated Emissions Anechoic	CISPR 25 (2002, 2008), Section 6.4; CISPR 25 (2016), Section 6.5; CS-11979, Section 5.3; CS.00054, Section 5.6.3; GMW 3097, Section 3.3.1; EMC-CS-2009.1 (RE 310); FMC1278 (RE310);

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Test Technology:	Test Method(s) [1]:
Vehicle Radiated Emissions	CISPR 12; CISPR 36; ICES-002; ECE Regulation 10.06 Annex 5
Bulk Current Injection (BCI)	ISO 11452-4; CS-11979, Section 6.1; CS.00054, Section 5.8.1; GMW 3097, Section 3.4.1; SAE J1113-4; EMC-CS-2009.1 (RI112); FMC1278 (RI112); ECE Regulation 10.06 Annex 9
Radiated Immunity Anechoic *(Including Radar Pulse)*	ISO 11452-2; ISO 11452-5; CS-11979, Section 6.2; CS.00054, Section 5.8.2; GMW 3097, Section 3.4.2; EMC-CS-2009.1 (RI114); FMC1278 (RI114); SAE J1113-21; ECE Regulation 10.06 Annex 9
Radiated Immunity Magnetic Field	ISO 11452-8
Radiated Immunity Reverb	ISO/IEC 61000-4-21; GMW 3097, Section 3.4.3; EMC-CS-2009.1 (RI114); FMC1278 (RI114); ISO 11452-11
Radiated Immunity *(Portable Transmitters)*	ISO 11452-9; EMC-CS-2009.1 (RI115); FMC1278 (RI115)
Vehicle Radiated Immunity (ALSE)	ISO 11451-2; ECE Regulation 10.06 Annex 6
Vehicle Product Specific EMC Standards	EN 14982; EN ISO 13309; ISO 13766; EN 50498; EC Regulation No. 2015/208; EN 55012
Electrical Loads	ISO 16750-2
Emissions Radiated and Conducted (3m Semi-anechoic chamber, up to 40 GHz)	47 CFR, FCC Part 15 B (using ANSI C63.4:2014); 47 CFR, FCC Part 18 (using FCC MP-5:1986); ICES-001; ICES-003; ICES-005; IEC/CISPR 11, Ed. 4.1 (2004-06); AS/NZS CISPR 11 (2004); IEC/CISPR 11 Ed 5 (2009-05) + A1 (2010); KN 11 (2008-5) with RRL Notice No. 2008-3 (May 20, 2008); CISPR 11; EN 55011; KS C 9811; CNS 13803 (1997, 2003); CISPR 14-1; EN 55014-1; AS/NZS CISPR 14.1; CISPR 16-2-1 (2008); CISPR 16-2-1; KS C 9814-1; KN 14-1; IEC/CISPR 22 (1997); EN 55022 (1998) + A1(2000); EN 55022 (1998) + A1(2000) + A2(2003); EN 55022 (2006); IEC/CISPR 22 (2008-09); AS/NZS CISPR 22 (2004); AS/NZS CISPR 22, 3rd Edition (2006); KN 22 (up to 6 GHz); CNS 13438 (up to 6 GHz); VCCI V-3 (up to 6 GHz); CISPR 32; EN 55032; KS C 9832; KN 32; ECE Regulation 10.06 Annex 7 (Broadband) ECE Regulation 10.06 Annex 8 (Narrowband) ECE Regulation 10.06 Annex 14 (Conducted)

Test Technology:	Test Method(s) [1]:
Emissions (cont'd)	
Cellular Radiated Spurious Emissions	ETSI TS 151 010-1 GSM; 3GPP TS 51.010-1, Sec 12; ETSI TS 134 124 UMTS; 3GPP TS 34.124; ETSI TS 136 124 LTE; E-UTRA; 3GPP TS 36.124
Current Harmonics	IEC 61000-3-2; EN 61000-3-2; KN 61000-3-2; KS C 9610-3-2; ECE Regulation 10.06 Annex 11
Flicker and Fluctuations	IEC 61000-3-3; EN 61000-3-3; KN 61000-3-3; KS C 9610-3-3; ECE Regulation 10.06 Annex 12
Immunity	
Electrostatic Discharge	IEC 61000-4-2, Ed. 1.2 (2001); IEC 61000-4-2 (1995) + A1(1998) + A2(2000); EN 61000-4-2 (1995); EN 61000-4-2 (2009-05); KN 61000-4-2 (2008-5); RRL Notice No. 2008-4 (May 20, 2008); IEC 61000-4-2; EN 61000-4-2; KN 61000-4-2; KS C 9610-4-2; IEEE C37.90.3 2001
Radiated Immunity	IEC 61000-4-3 (1995) + A1(1998) + A2(2000); IEC 61000-4-3, Ed. 3.0 (2006-02); IEC 61000-4-3, Ed. 3.2 (2010); KN 61000-4-3 (2008-5); RRL Notice No. 2008-4 (May 20, 2008); IEC 61000-4-3; EN 61000-4-3; KN 61000-4-3; KS C 9610-4-3; IEEE C37.90.2 2004
Electrical Fast Transient/Burst	IEC 61000-4-4, Ed. 2.0 (2004-07); IEC 61000-4-4, Ed. 2.1 (2011); IEC 61000-4-4 (1995) + A1(2000) + A2(2001); KN 61000-4-4 (2008-5); RRL Notice No. 2008-5 (May 20, 2008); IEC 61000-4-4; EN 61000-4-4; KN 61000-4-4; KS C 9610-4-4; ECE Regulation 10.06 Annex 15
Surge	IEC 61000-4-5 (1995) + A1(2000); IEC 61000-4-5, Ed 1.1 (2005-11); EN 61000-4-5 (1995) + A1(2001); KN 61000-4-5 (2008-5); RRL Notice No. 2008-4 (May 20, 2008); IEC 61000-4-5; EN 61000-4-5; KN 61000-4-5; KS C 9610-4-5; IEEE C37.90.1 2012; IEEE STD C62.41.2 2002; ECE Regulation 10.06 Annex 16

Test Technology:	Test Method(s) [1]:
Immunity (cont'd)	
Conducted Immunity	IEC 61000-4-6 (1996) + A1(2000); IEC 61000-4-6, Ed 2.0 (2006-05); IEC 61000-4-6 Ed. 3.0 (2008); KN 61000-4-6 (2008-5); RRL Notice No. 2008-4 (May 20, 2008); EN 61000-4-6 (1996) + A1(2001); IEC 61000-4-6; EN 61000-4-6; KN 61000-4-6; KS C 9610-4-6
Power Frequency Magnetic Field Immunity (*Down to 3 A/m*)	IEC 61000-4-8 (1993) + A1(2000); IEC 61000-4-8 (2009); EN 61000-4-8 (1994) + A1(2000); KN 61000-4-8 (2008-5); RRL Notice No. 2008-4 (May 20, 2008); IEC 61000-4-8; EN 61000-4-8; KN 61000-4-8; KS C 9610-4-8
Voltage Dips, Short Interrupts, and Line Voltage Variations	IEC 61000-4-11, Ed. 2 (2004-03); KN 61000-4-11 (2008-5); RRL Notice No. 2008-4 (May 20, 2008); IEC 61000-4-11; EN 61000-4-11; KN 61000-4-11; KS C 9610-4-11
Ring Wave	IEC 61000-4-12, Ed. 2 (2006-09); EN 61000-4-12:2006; IEC 61000-4-12; EN 61000-4-12; KN 61000-4-12; IEEE STD C62.41.2 2002
Generic and Product Specific EMC Standards	IEC/EN 61000-6-1; AS/NZS 61000-6-1; KN 61000-6-1; KS C 9610-6-1; IEC/EN 61000-6-2; AS/NZS 61000-6-2; KN 61000-6-2; KS C 9610-6-2; IEC/EN 61000-6-3; AS/NZS 61000-6-3; KN 61000-6-3; KS C 9610-6-3; IEC/EN 61000-6-4; AS/NZS 61000-6-4; KN 61000-6-4; KS C 9610-6-4; EN 50130-4; EN 61326-1; EN 50121-3-2; EN 12895; EN 50270; EN 50491-1; EN 50491-2; EN 50491-3; EN 55015; EN 60730-1; EN 60945; IEC 60533; EN 61326-2-6; EN 61800-3; IEC/CISPR 14-2; EN 55014-2; AS/NZS CISPR 14.2; KN 14-2; KS C 9814-2; IEC/CISPR 24; AS/NZS CISPR 24; EN 55024; KN 24; IEC/CISPR 35; AS/NZS CISPR 35; EN 55035; KN 35; KS C 9835; IEC 60601-1-2; JIS T0601-1-2
TxRx EMC Requirements	EN 301 489-1; EN 301 489-3; EN 301 489-9; EN 301 489-17; EN 301 489-19; EN 301 489-20

Test Technology:	Test Method(s) [1]:
European Radio Test Standards	ETSI EN 300 086-1; ETSI EN 300 086-2; ETSI EN 300 113-1; ETSI EN 300 113-2; ETSI EN 300 220-1; ETSI EN 300 220-2; ETSI EN 300 220-3-1; ETSI EN 300 220-3-2; ETSI EN 300 330-1; ETSI EN 300 330-2; ETSI EN 300 440-1; ETSI EN 300 440-2; ETSI EN 300 422-1; ETSI EN 300 422-2; ETSI EN 300 328; ETSI EN 301 893; ETSI EN 301 511; ETSI EN 301 908-1; ETSI EN 908-2; ETSI EN 908-13; ETSI EN 303 413; ETSI EN 302 502; EN 303 340; EN 303 345-2; EN 303 345-3; EN 303 345-4
Canadian Radio Tests	RSS-102 (RF Exposure Evaluation [MEAS]); RSS-102 (Nerve Stimulation [MEAS]) (5Hz to 400kHz); SPR-002; RSS-111; RSS-112; RSS-117; RSS-119; RSS-123; RSS-125; RSS-127; RSS-130; RSS-131; RSS-132; RSS-133; RSS-134; RSS-135; RSS-137; RSS-139; RSS-140; RSS-141; RSS-142; RSS-170; RSS-181; RSS-182; RSS-191; RSS-192; RSS-194; RSS-195; RSS-196; RSS-197; RSS-199; RSS-210; RSS-211; RSS-213; RSS-215; RSS-216; RSS-220; RSS-222; RSS-236; RSS-238; RSS-243; RSS-244; RSS-247; RSS-248; RSS-251; RSS-252; RSS-287; RSS-288; RSS-310; RSS-GEN
Mexico Radio Tests	IFT-008-2015; NOM-208-SCFI-2016
Japan Radio Tests	Radio Law No. 131, Ordinance of MPT No. 37, 1981, MIC Notification No. 88:2004, Table No. 22-11; ARIB STD-T66, Regulation 18
Taiwan Radio Tests	LP-0002 (July 15, 2020)
Australia/New Zealand Radio Tests	AS/NZS 4268; Radiocommunications (Short Range Devices) Standard (2014)
Hong Kong Radio Tests	HKCA 1039 Issue 6; HKCA 1042; HKCA 1033 Issue 7; HKCA 1061; HKCA 1008; HKCA 1043; HKCA 1057; HKCA 1073
Korean Radio Test Standards	KN 301 489-1; KN 301 489-3; KN 301 489-9; KN 301 489-17; KN 301 489-52; KS X 3124; KS X 3125; KS X 3130; KS X 3126; KS X 3129
Vietnam Radio Test Standards	QCVN 47:2015/BTTTT; QCVN 54:2020/BTTTT; QCVN 55:2011/BTTTT; QCVN 65:2013/BTTTT; QCVN 73:2013/BTTTT; QCVN 74:2020/BTTTT; QCVN 112:2017/BTTTT; QCVN 117:2020//BTTTT
Vietnam EMC Test Standards	QCVN 18:2014/BTTTT; QCVN 86:2019/BTTTT; QCVN 96:2015/BTTTT; QCVN 118:2018/BTTTT

Test Technology:	Test Method(s) [1]:
Unlicensed Radio Frequency Devices *(3 Meter Semi-Anechoic Room)*	47 CFR FCC Part 15C, 15D, 15E, 15F, 15G, 15H (using ANSI C63.10:2013, ANSI C63.17:2013 and FCC KDB 905462 D02 (v02))
Licensed Radio Service Equipment	47 CFR FCC Parts 20, 22, 24, 25, 27, 30, 73, 74, 80, 87, 90, 95, 96, 97, 101 (using ANSI/TIA-603-E, TIA-102.CAAA-E, ANSI C63.26:2015)
OTA (Over the Air) Performance GSM, GPRS, EGPRS UMTS (W-CDMA) LTE including CAT M1 A-GPS for UMTS/GSM LTS A-GPS, A-GLONASS, SIB8/SIB16 Large Device/Laptop/Tablet Testing Integrated Device Testing WiFi 802.11 a/b/g/n/a	CTIA Test Plan for Wireless Device Over-the-Air Performance (Method for Measurement for Radiated Power and Receiver Performance) V3.8.2; CTIA Test Plan for RF Performance Evaluation of WiFi Mobile Converged Devices V2.1.0
Electrical Measurements and Simulation AC Voltage / Current (1mV to 5kV) 60 Hz (0.1V to 250V) up to 500 MHz (1μA to 150A) 60 Hz DC Voltage / Current (1mV to 15 kV) / (1μA to 10A) Power Factor / Efficiency / Crest Factor (Power to 30kW) Resistance (1mΩ to 4000MΩ) Surge (Up to 10 kV / 5 kA) (Combination Wave and Ring Wave)	FAA AC 150/5345-10H FAA AC 150/5345-43J FAA AC 150/5345-44K FAA AC 150/5345-46E FAA AC 150/5345-47C FAA EB 67D

On the following products and materials:
Telecommunications Terminal Equipment (TTE), Radio Equipment, Network Equipment, Information Technology Equipment (ITE), Automotive Electronic Equipment, Automotive Hybrid Electronic Devices, Maritime Navigation and Radio Communication Equipment and Systems, Vehicles, Boats and Internal Combustion Engine Driven Devices, Automotive, Aviation, and General Lighting Products, Medical Electrical Equipment, Motors, Industrial, Scientific and Medical (ISM) Radio-Frequency Equipment, Household Appliances, Electric Tools, Low-voltage Switchgear and Control gear, Programmable Controllers, Electrical Equipment for Measurement, Control and Laboratory Use, Base Materials, Power and Data Transmission Cables and Connectors

[1] When the date, edition, version, etc. is not identified in the scope of accreditation, laboratories may use the version that immediately precedes the current version for a period of one year from the date of publication of the standard measurement method, per part C., Section 1 of A2LA *R101 - General Requirements- Accreditation of ISO-IEC 17025 Laboratories*.

Testing Activities Performed in Support of FCC Certification in Accordance with 47 Code of Federal Regulations and FCC KDB 974614, Appendix A, Table A.1[2]

Rule Subpart/Technology	Test Method	Maximum Frequency (MHz)
Unintentional Radiators Part 15B	ANSI C63.4:2014	40000
Industrial, Scientific, and Medical Equipment Part 18	FCC MP-5 (February 1986)	40000
Intentional Radiators Part 15C	ANSI C63.10:2013	40000
Unlicensed Personal Communication Systems Devices Part 15D	ANSI C63.17:2013	40000
U-NII without DFS Intentional Radiators Part 15E	ANSI C63.10:2013	40000
U-NII with DFS Intentional Radiators Part 15E	FCC KDB 905462 D02 (v02)	40000
UWB Intentional Radiators Part 15F	ANSI C63.10:2013	40000
BPL Intentional Radiators Part 15G	ANSI C63.10:2013	40000
White Space Device Intentional Radiators Part 15H	ANSI C63.10:2013	40000
Commercial Mobile Services (FCC Licensed Radio Service Equipment) Parts 22 (cellular), 24, 25 (below 3 GHz), and 27	ANSI/TIA-603-E; TIA-102.CAAA-E; ANSI C63.26:2015	40000
General Mobile Radio Services (FCC Licensed Radio Service Equipment) Parts 22 (non-cellular), 90 (below 3 GHz), 95, 97, and 101 (below 3 GHz)	ANSI/TIA-603-E; TIA-102.CAAA-E; ANSI C63.26:2015	40000
Citizens Broadband Radio Services (FCC Licensed Radio Service Equipment) Part 96	ANSI/TIA-603-E; TIA-102.CAAA-E; ANSI C63.26:2015	40000

Testing Activities Performed in Support of FCC Certification in Accordance with 47 Code of Federal Regulations and FCC KDB 974614, Appendix A, Table A.1[2]

Rule Subpart/Technology	Test Method	Maximum Frequency (MHz)
Maritime and Aviation Radio Services		
Parts 80 and 87	ANSI/TIA-603-E; ANSI C63.26:2015	40000
Microwave and Millimeter Bands Radio Services		
Parts 25, 30, 74, 90 (above 3 GHz), 97 (above 3 GHz), and 101	ANSI/TIA-603-E; TIA-102.CAAA-E; ANSI C63.26:2015	40000
Broadcast Radio Services		
Parts 73 and 74 (below 3 GHz)	ANSI/TIA-603-E; TIA-102.CAAA-E; ANSI C63.26:2015	40000
Signal Boosters		
Part 20 (Wideband Consumer Signal Boosters, Provider-specific signal boosters, and Industrial Signal Boosters) Section 90.219	ANSI C63.26:2015	40000

[2] Accreditation does not imply acceptance to the FCC equipment authorization program. Please see the FCC website (https://apps.fcc.gov/oetcf/eas/) for a listing of FCC approved laboratories.

Accredited Laboratory

A2LA has accredited

ELITE ELECTRONIC ENGINEERING INC.

Downers Grove, IL

for technical competence in the field of

Electrical Testing

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 *General requirements for the competence of testing and calibration laboratories*. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (*refer to joint ISO-ILAC-IAF Communiqué dated April 2017*).

Presented this 19th day of May 2021.

Vice President, Accreditation Services
For the Accreditation Council
Certificate Number 1786.01
Valid to June 30, 2023

For the tests to which this accreditation applies, please refer to the laboratory's Electrical Scope of Accreditation.